

# **Embedded Flash Memory**

RAW NAND
MANAGED NAND
AUTOMOTIVE SOLUTIONS







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# Leading Supplier and Inventor of Flash Memory

Silica wafers are formed from highly pure, nearly defect-free single crystalline material: the starting point for any integrated circuits.

#### **INNOVATION IS OUR TRADITION**

In 1984 Toshiba invented a new type of semiconductor memory called flash memory. Later in 1987, NAND flash memory was developed that raised electronic equipment to the next level. The NAND flash market has grown rapidly, with flash memory becoming an internationally standardised memory device. KIOXIA, the inventor of flash memory, has thus carved out a path to a new era in which innovations are increased by the opportunities of NAND flash.

Under its new name, KIOXIA keeps this invention and continues to provide embedded memory solutions. Embedded memory connects us with the things that surround and serve us – for more efficiency, comfort and sustainability.

#### **SPEED UP DIGITAL PROCESSES**

Storing and processing data has always been an important aspect of all digital processes. But in the last years it increased to one of the key technologies for industry 4.0, smart mobility, cloud technology and artificial intelligence, because smart ideas and innovations have to be ready for markets right away – with high reliability of storage components.

With our embedded memory solutions, KIOXIA is the partner for all smart markets and fast moving industries. KIOXIA provides a highly grade of innovation combined with highly reliable security – now and in the future.

#### **PARTNERSHIP IS OUR PASSION**

Our success is based on our strong customer focus: Your metrics are our metrics. The result is a broad range of industry-leading flash-based storage solutions. Our products are designed to meet your specific engineering demands.

# KIOXIA EMBEDDED MEMORY – THE KEY TO A SMART FUTURE

"With progressive memory technology at the core, we offer products, services, and systems that create choice and define the future."

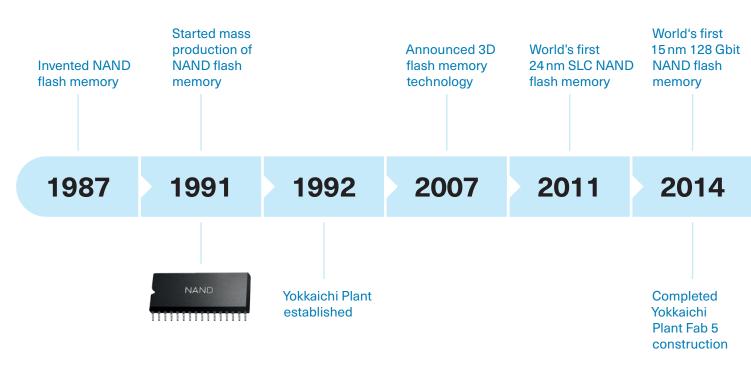




# **OUR LEGACY OF INNOVATI**



# THE INVENTOR OF FLASH MEMORY.



INNOVATIVE. AWARD-WINNING. TRUSTED.

#### Memory Solutions

Extensive product lineup

Excellent reliability & quality

Leading density & capacity

# ON COMES WITH US

With our proven track record of success and reputation for innovation, KIOXIA will build on our history as we continue our journey as an independent company...



Started mass production of 48-layer BiCS FLASH™

Prototyped QLC BiCS FLASH™ memory Started mass production of 96-layer BiCS FLASH™

KIOXIA Est. Oct 2019 Announced 162-layer BiCS FLASH™

2016

2017

2018

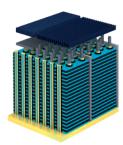
2019

2021

2022

**BiCS FLASH™** 

Completed Yokkaichi Plant new Fab 2 construction

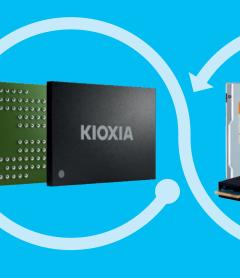


Completed Yokkaichi Plant Fab 6 construction

PM7

CD8

Completed Kitakami Plant K1 construction Yokkaichi Plant Y7 construction started Completed first phase of Yokkaichi Plant new Fab 7 construction Started construction of Kitakami Plant K2



#### SSD Solutions

In-house SoC & firmware

Latest interfaces & form factors

Broad portfolio of SSDs

Software Solutions

The future of high-density flash memory.



UPLIFTING THE WORLD WITH "MEMORY"

In 1987 KIOXIA introduced a new technology that has forever changed the way we live, work and play: NAND flash memory

As the inventor of the first flash memory, KIOXIA has been leading a new era by providing advanced memory solutions to enrich people's lives.

Back in 1987, it would have been hard to imagine all of the ways that this brand-new technology would impact the world. NAND flash memory has introduced an entire new technological era. New applications, such as smartphones, tablets and notebooks, automotive infotainment systems, gaming, wearables, data centers and so much more, have been developed that would not exist in the form they are today without this flash memory technology.

From the invention of flash memory to today's renowned BiCS FLASH™, KIOXIA continues to pioneer innovative memory solutions with high quality and reliability. The company's BiCS FLASH™ 3D flash memory technology is an important component in almost all electronic devices where data needs to be stored.

By evolving "memory", KIOXIA creates uplifting experiences and changes the world.

#### The Evolution of Applications - From Then to Now

Some of the first flash applications are almost unrecognizable today. And, many new applications have been born that would not have been possible without KIOXIA's invention.

THE EARLIEST USERS OF FLASH – IN THE 1990S:



Digital telephone Bard answering machines Scar



Barcode Scanners



Digital Cameras



MP3 Players



Personal Digital Assistants



Smartphones



Tablets and Notebooks



Automotive



Smart Homes/ Buildings/Cities



SSDs

FLASH APPLICATIONS TODAY:



Cloud/Edge Computing



Gaming/ AR/VR



Wearables & Digital Health



Industrial Automation



Security/ Surveillance

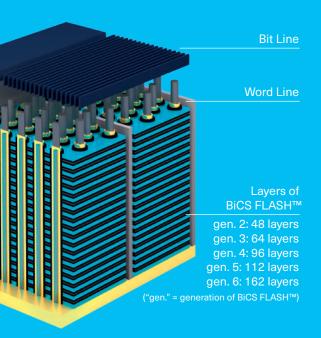


# **Embedded Flash Memory**

SLC NAND BENAND™

e-MMC UFS

KIOXIA 3D-Technology BiCS FLASH™



KIOXIA offers a wide range of advanced flash memory technology for all kind of applications like consumer electronics, mobile technology and industrial applications such as robotics.

NAND flash memory requires an appropriate management, which has to cover tasks like Bad Block Management, Wear Leveling, Garbage Collection and ECC Error Correction. Either these functions are supported by the host system in combination with raw NAND memory, or it is covered instantly inside a managed NAND by utilizing an integrated memory controller.

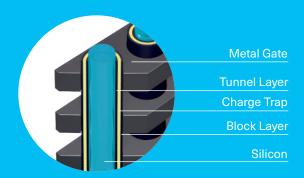
The selection between these basic different approaches to control a NAND memory defines the individual host requirements and interface options. For managed NAND there are JEDEC specified Standard-Interfaces supported, enabling the developer to easily design the required memory solution.

#### **RAW NAND**

With raw SLC NAND and BENAND™ we provide high endurance and data retention for sensitive or frequently used data.

#### **MANAGED NAND**

For efficient and easy to integrate storage systems, managed NAND like e-MMC and UFS are the preferred solutions. Offering broadly accepted standard interfaces and packages, in combination with high speed interfaces, they are the optimal selection for many application in the industrial, mobile and automotive market.



Our BiCS FLASH™ 3D flash memory technology with 64-, 96-, 112- and 162-layer stacking make a powerful memory solutions possible. It gives BiCS FLASH™ far higher die area density compared to 2D NAND. BiCS FLASH™ reduces the chip size by optimizing both circuit technology and the manufacturing process.

As a result, this technology can achieve similar reliability as 2D-MLC (2bit/cell) while utilizing 3D-TLC (3bit/cell) structure.





### **BENAND<sup>TM</sup>**

#### SLC NAND with embedded ECC

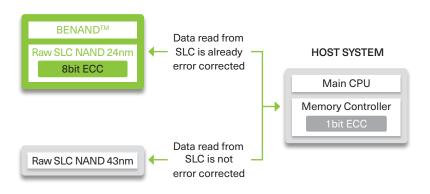
BENAND™ (Built-in ECC NAND) is a SLC NAND memory device which has an internal hardware ECC engine.

Using BENAND™ it is possible for customers to use the 24nm SLC NAND flash memory technology even when their platform cannot support higher bit ECC.

#### **SPECIFICATIONS**

| FEATURES                    | BENAND™ (SLC+ECC)                |
|-----------------------------|----------------------------------|
| Density                     | 1 Gbit – 8 Gbit                  |
| Technology                  | 2D-SLC                           |
| ECC (Error Correction Code) | Embedded on Memory Chip          |
| Temperature                 | -40° C to 85° C<br>0° C to 70° C |
| Package                     | TSOP and BGA                     |

#### BENAND™ – SLC WITH EMBEDDED ECC FOR BOM REDUCTION AND SYSTEM FLEXIBILITY



#### **CAPACITIES:**









#### **KEY FEATURES:**

- 1 Gbit 8 Gbit
- Compatibility of SLC NAND Interface, basic functions and command sequence follows SLC NAND.
- Same hardware interface and package as raw SLC

#### **ADVANTAGES**

- Broad line-up to cover customers' demands for different densities
- 24nm technology for cost optimisation
- Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48% (up to 8 Gbit)
- With BENAND™ no ECC operation is required on the host side

- Industrial Applications
- Consumer Electronics
- · Multimedia Applications
- · Smart Metering & Intelligent Lighting
- Smart Applications





## **SLC NAN**

#### **Reliability and Performance**

KIOXIA's advanced flash memory technology offers SLC NAND providing best in class endurance and data retention for sensitive or frequently used data in a system. For long lasting products or systems working with extremely high data throughput between the host and the memory, KIOXIA SLC is the optimal solution.

#### **SPECIFICATIONS**

| FEATURES                    | SLC NAND                         |
|-----------------------------|----------------------------------|
| Density                     | 1 Gbit – 256 Gbit                |
| Technology                  | 2D-SLC                           |
| ECC (Error Correction Code) | Required on Host Side            |
| Temperature                 | -40° C to 85° C<br>0° C to 70° C |
| Package                     | TSOP and BGA                     |

#### **CAPACITIES:**



















#### **KEY FEATURES:**

- 1 Gbit 256 Gbit
- · Extended temperature range
- TSOP and BGA package

#### **ADVANTAGES**

- · Broad line up to cover customers' demands for different densities
- · 24nm technology for cost optimisation
- · Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48 % (up to 8 Gbit)

- · Industrial Applications
- Consumer Electronics
- · Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications





# e-MMC

#### **Highly-efficient Storage**

e-MMC is a family of advanced and highly efficient NAND flash memory with an integrated controller for enhanced memory management. Based on an interface standardised by JEDEC, KIOXIA's e-MMC offers the optimal solution for applications where higher data volumes need to be stored in an efficient way.

#### **SPECIFICATIONS**

| FEATURES      | e-MMC                        | EXTENDED TEMP. e-MMC |  |  |  |
|---------------|------------------------------|----------------------|--|--|--|
| Density       | 4 GB – 128 GB                | 8 GB – 64 GB         |  |  |  |
| Technology    | 2D-MLC / 3D-TLC              | 2D-MLC               |  |  |  |
| JEDEC Version | 5.0 / 5.1                    | 5.1                  |  |  |  |
| Temperature   | -25°C to 85°C -40°C to 105°C |                      |  |  |  |
| Package       | 153 ball FBGA (11.5 x 13 mm) |                      |  |  |  |

#### e-MMC - UTILIZING BiCS FLASH™

With the innovative BiCS FLASH™ 3D flash memory technology in combination with the new charge trap cell structure, Kioxia continuously provide the best-in-class family of reliable, easy to integrate, and efficient e-MMCs. These new e-MMCs represent an attractive alternative with superior price competitiveness, longevity, and higher performance.

#### **CAPACITIES:**













#### **KEY FEATURES:**

- 4 GB 128 GB
- 2D-MLC / 3D-TLC technology
- e-MMC Version 5.0 and 5.1
- Integrated memory management:
  - Error correction code
  - Bad block management
  - Wear-levelling
  - Garbage collection
- Standard and extended temperature range of up to 105°C
- FBGA package

#### **ADVANTAGES**

- Higher interface speed HS400 in accordance with JEDEC 5.x
- Managed memory
- Package, interface, features, commands, etc. are standard

- · Industrial Applications
- · Consumer Electronics
- Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications







### UFS

#### **High Performance Storage**

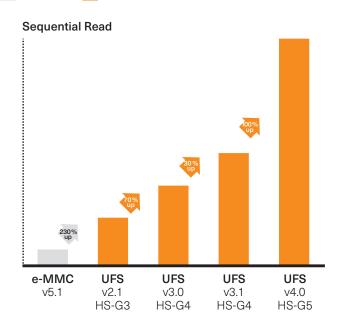
For applications demanding for superior interface performance, KIOXIA is offering a broad line-up of new UFS memory products. Utilizing a full duplex serial high-speed interface, it is compliant with the latest UFS Version 3.1 and 4.0. In combination with the embedded memory management, it offers a highly efficient and excellent performing storage solution. UFS memory enables next generation mobile devices to take full advantage of the connectivity benefits of 5G, leading to faster downloads and reduced lag time – and improved user experience.

#### **SPECIFICATIONS**

| FEATURES      | UFS - UNIVERSAL FLASH STORAGE               |
|---------------|---|
| Density       | 128 GB – 1 TB                               |
| Technology    | 3D-TLC                                      |
| JEDEC Version | 3.1 and 4.0                                 |
| Temperature   | -25° C to 85° C                             |
| Package       | 153 ball FBGA (11.5 x 13 mm and 11 x 13 mm) |

#### COMPARING THE PERFORMANCE:









#### **CAPACITIES:**









#### **KEY FEATURES:**

- 128 GB 1 TB
- BiCS FLASH™
- · 3D-TLC technology
- UFS Version 3.1 and 4.0
- · Integrated memory management:
  - Error correction code
  - Bad block management
  - Wear-levelling
  - Garbage collection
- WriteBooster: Enables significantly faster write speeds
- Standard temperature range up to 85°C
- FBGA package
- High Speed Serial interface

#### **ADVANTAGES**

- High speed interface up to 1160 MB/ sec / 2320 MB/sec / 4640 MB/sec
- Managed memory
- Package, interface, features, commands, etc. are standard
- Utilises high quality KIOXIA BiCS FLASH™ memory in combination with a KIOXIA origin developed controller

- Consumer Electronics
- Multimedia Applications
- Industrial Applications
- Smart Applications



# e-MMC Automotive

#### e-MMC for Automotive Demands

E-mobility, autonomous driving, higher demands on safety and sustainability – automotive industries are once more leading in innovation and technology. For these smart and connected vehicles, reliable storage solutions are mandatory. KIOXIA provides one of the key technologies for wireless communication, information systems and Advanced Driver Assistance Systems (ADAS).

|         |                 |               |            |             |  | I       |
|---------|-----------------|---------------|------------|-------------|--|---------|
| DENSITY | PART NUMBER     | JEDEC         | POWER SUPI | PLY VOLTAGE | TEMPERATURE                              | PACKAGE |
| DENOTT  | TART NOMBER     | VERSION       | VCC (V)    | VCCQ (V)    | TEINI EIVATOILE                          | TACKAGE |
| 8 GB    | THGBMJG6C1LBAC7 |               |            |             |  |         |
| 16 GB   | THGBMJG7C2LBAC8 | e-MMC 5.1     | 2.7 – 3.6  | 1.7 – 1.95  | -40°C to 105°C<br>(Automotive            |         |
| 32 GB   | THGBMJG8C4LBAC8 | e-iviivic 5.1 | 2.7 - 3.0  | 2.7 – 3.6   | Grade 2)                                 | FBGA153 |
| 64 GB   | THGBMJG9C8LBAC8 |               |            |             |  |         |
| 32 GB   | THGAMVG8T13BAA7 |               | 2.7 – 3.6  | 1.7 – 1.95  | -40°C to 85°C<br>(Automotive<br>Grade 3) |         |
| 64 GB   | THGAMVG9T23BAA8 | e-MMC 5.1     |            |             |  |         |
| 128 GB  | THGAMVT0T43BAA8 | e-iviivio 5.1 |            |             |  |         |
| 256 GB  | THGAMVT1T83BAA5 |               |            |             |  |         |
| 32 GB   | THGAMVG8T13BAB7 |               |            |             |  |         |
| 64 GB   | THGAMVG9T23BAB8 | e-MMC 5.1     | 2.7 – 3.6  | 1.7 – 1.95  | -40°C to 105°C<br>(Automotive            |         |
| 128 GB  |                 |               | 2.7 - 3.0  | 1.7 - 1.95  | Grade 2)                                 |         |
| 256 GB  | THGAMVT1T83BAB5 |               |            |             |  |         |

#### **CAPACITIES:**











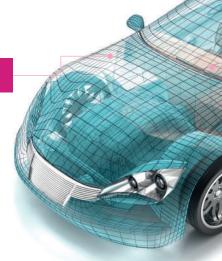


#### **KEY FEATURES:**

- AEC-Q100 qualified
- Compliant with IATF16949
- Temperature range:
   Automotive Grade 2 & Grade 3
   (-40° C ~ +105° C & -40° C ~ +85° C)
- Compliant with e-MMC 5.1
- Highly reliable technology 2D-MLC and 3D-TLC
- Integrated memory management:
  - Error correction code
  - Bad block management
  - Wear-levelling
  - Garbage collection
- Automotive specific functions



ADAS DOMAIN CONTROLLER









## **UFS** Automotive

#### **UFS for Automotive Demands**

Accelerated processing power and increased data storage capacity are the keys to enabling the next generation of automotive systems. For applications demanding for superior interface performance, KIOXIA is offering a line-up of new UFS automotive memory products. Utilizing a full duplex serial high-speed interface, it is compliant with the UFS Version 3.1.

| DENSITY | PART NUMBER     | JEDEC    | POWER SUPPLY VOLTAGE |                   | TEMPERATURE                              | PACKAGE |                               |         |
|---------|-----------------|----------|----------------------|-------------------|--|---------|-------------------------------|---------|
| DENSITY | PART NUMBER     | VERSION  | VCC (V)              | VCCQ (V)          | TEMPERATURE                              | PACKAGE |                               |         |
| 64 GB   | THGJFGG9T15BAA8 |          |                      |                   |  |         |                               |         |
| 128 GB  | THGJFGT0T25BAA8 | UFS 3.1  | 2.4 – 2.7            | 1.14 to<br>1.26V  | -40°C to 85°C<br>(Automotive<br>Grade 3) | FBGA153 |                               |         |
| 256 GB  | THGJFGT1T45BAA8 | 01 3 3.1 | 2.7 – 3.6            |                   |  |         |                               |         |
| 512 GB  | THGJFGT2T85BAA5 |          |                      |                   |  |         |                               |         |
| 64 GB   | THGJFGG9T15BAB8 | LIEC 2.4 | LIFO 2.4             | UFS 3.1 2.4 – 2.7 |  | 1.14 to | -40°C to 105°C<br>(Automotive | FBGA153 |
| 128 GB  | THGJFGT0T25BAB8 |          |                      |                   | 2.4 – 2.7                                |         |                               |         |
| 256 GB  | THGJFGT1T45BAB8 | 01 3 3.1 | 2.7 – 3.6            | 1.26V             | Grade 2)                                 | FDGA153 |                               |         |
| 512 GB  | THGJFGT2T85BAB5 |          |                      |                   |  |         |                               |         |

#### **CAPACITIES:**



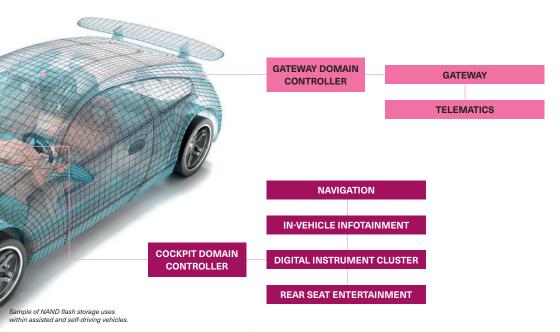






#### **KEY FEATURES:**

- AEC-Q100 qualified
- Compliant with IATF16949
- Temperature range:
  - Automotive Grade 3 (-40°C ~ +85°C)
  - Automotive Grade 2 (-40°C ~ +105°C)
- Highly reliable technology 3D-TLC
- Compliant with UFS 3.1
- Integrated memory management:
  - Error correction code
  - Bad block management
  - Wear-levelling
  - Garbage collection
- Automotive specific functions







# **Product List**

#### **SLC NAND**

| DENSITY  | PART NUMBER     | TECHN. | PAGE SIZE           | VCC  | ECC          | TEMPERATURE     | PACKAGE        |
|----------|-----------------|--------|---------------------|------|--------------|-----------------|----------------|
|          | TC58NVG0S3HTA00 |        | (2048+128) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TC58NYG0S3HBAI4 |        | (2048+128) x 8 bit  | 1.8V |              | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NVG0S3HTAI0 | 00.010 | (2048+128) x 8 bit  | 3.3V | Ob it /E1 OD | -40°C to 85°C   | 48TSOP 12 x 20 |
| 1 Gbit   | TC58NVG0S3HBAI4 | 2D-SLC | (2048+128) x 8 bit  | 3.3V | 8bit/512B    | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NYG0S3HBAI6 |        | (2048+128) x 8 bit  | 1.8V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TC58NVG0S3HBAI6 |        | (2048+128) x 8 bit  | 3.3V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TC58NVG1S3HTA00 |        | (2048+128) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TC58NYG1S3HBAI4 |        | (2048+128) x 8 bit  | 1.8V |              | -40°C to 85°C   | 63BGA 9 x 11   |
| 0.01.11  | TC58NVG1S3HTAI0 | 00.010 | (2048+128) x 8 bit  | 3.3V | 01.77/54.00  | -40°C to 85°C   | 48TSOP 12 x 20 |
| 2 Gbit   | TC58NVG1S3HBAI4 | 2D-SLC | (2048+128) x 8 bit  | 3.3V | 8bit/512B    | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NYG1S3HBAI6 |        | (2048+128) x 8 bit  | 1.8V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TC58NVG1S3HBAI6 |        | (2048+128) x 8 bit  | 3.3V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TH58NVG2S3HTA00 |        | (2048+128) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TC58NVG2S0HTA00 |        | (4096+256) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TC58NVG2S0HTAI0 |        | (4096+256) x 8 bit  | 3.3V |              | -40°C to 85°C   | 48TSOP 12 x 20 |
| 4 Gbit   | TH58NVG2S3HTAI0 |        | (2048+128) x 8 bit  | 3.3V |              | -40°C to 85°C   | 48TSOP 12 x 20 |
|          | TH58NVG2S3HBAI4 | 2D-SLC | (2048+128) x 8 bit  | 3.3V | 8bit/512B    | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TH58NYG2S3HBAI4 |        | (2048+128) x 8 bit  | 1.8V |              | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NVG2S0HBAI4 |        | (4096+256) x 8 bit  | 3.3V |              | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NYG2S0HBAI4 |        | (4096+256) x 8 bit  | 1.8V |              | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TC58NVG2S0HBAI6 |        | (4096+256) x 8 bit  | 3.3V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TC58NYG2S0HBAI6 |        | (4096+256) x 8 bit  | 1.8V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TH58NVG3S0HTA00 |        | (4096+256) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TH58NVG3S0HBAI4 |        | (4096+256) x 8 bit  | 3.3V |              | -40°C to 85°C   | 63BGA 9 x 11   |
|          | TH58NYG3S0HBAI4 |        | (4096+256) x 8 bit  | 1.8V |              | -40°C to 85°C   | 63BGA 9 x 11   |
| 8 Gbit   | TH58NVG3S0HTAI0 | 2D-SLC | (4096+256) x 8 bit  | 3.3V | 8bit/512B    | -40°C to 85°C   | 48TSOP 12 x 20 |
|          | TH58NVG3S0HBAI6 |        | (4096+256) x 8 bit  | 3.3V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TH58NYG3S0HBAI6 |        | (4096+256) x 8 bit  | 1.8V |              | -40°C to 85°C   | 67BGA 6.5 x 8  |
|          | TH58NVG4S0HTA20 |        | (4096+256) x 8 bit  | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
| 16 Gbit  | TH58NVG4S0HTAK0 | 2D-SLC | (4096+256) x 8 bit  | 3.3V | 8bit/512B    | -40°C to 85°C   | 48TSOP 12 x 20 |
|          | TC58NVG5H2HTA00 |        | (8192+1024) x 8 bit | 3.3V |              | 0°C to 70°C     | 48TSOP 12 x 20 |
| 32 Gbit  | TC58NVG5H2HTAI0 | 2D-SLC | (8192+1024) x 8 bit | 3.3V | 24bit/1024B  | -40°C to 85°C   | 48TSOP 12 x 20 |
|          | TH58NVG6H2HTAK0 |        | (8192+1024) x 8 bit | 3.3V |              | -40°C to 85°C   | 48TSOP 12 x 20 |
| 64 Gbit  | TH58NVG6H2HTA20 | 2D-SLC | (8192+1024) x 8 bit | 3.3V | 24bit/1024B  | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TH58NVG7H2HTAK0 |        | (8192+1024) x 8 bit | 3.3V |              | -40° C to 85° C | 48TSOP 12 x 20 |
| 28 Gbit  | TH58NVG7H2HTA20 | 2D-SLC | (8192+1024) x 8 bit | 3.3V | 24bit/1024B  | 0°C to 70°C     | 48TSOP 12 x 20 |
|          | TH58TEG8H2HBA89 |        | (8192+1024) x 8 bit | 3.3V |              | 0°C to 70°C     | 132BGA 12x18   |
| 256 Gbit | TH58TEG8H2HBAS9 | 2D-SLC | (8192+1024) x 8 bit | 3.3V | 24bit/1024B  | -40°C to 85°C   | 132BGA 12x18   |

# **Product List**

#### $\mathbf{BENAND^{\mathsf{TM}}}$

| DENSITY | PART NUMBER     | TECHN. | PAGE SIZE          | VCC  | ECC          | TEMPERATURE   | PACKAGE        |
|---------|-----------------|--------|--------------------|------|--------------|---------------|----------------|
|         | TC58BVG0S3HTA00 |        | (2048+64) x 8 bit  | 3.3V |              | 0°C to 70°C   | 48TSOP 12 x 20 |
| 4.01.7  | TC58BYG0S3HBAI4 |        | (2048+64) x 8 bit  | 1.8V |              | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BVG0S3HTAI0 | 2D-SLC | (2048+64) x 8 bit  | 3.3V | internal ECC | -40°C to 85°C | 48TSOP 12 x 20 |
| 1 Gbit  | TC58BVG0S3HBAI4 | 2D-3LC | (2048+64) x 8 bit  | 3.3V | Internal ECC | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BYG0S3HBAI6 |        | (2048+64) x 8 bit  | 1.8V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TC58BVG0S3HBAI6 |        | (2048+64) x 8 bit  | 3.3V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TC58BVG1S3HTA00 |        | (2048+64) x 8 bit  | 3.3V |              | 0°C to 70°C   | 48TSOP 12 x 20 |
|         | TC58BYG1S3HBAI4 |        | (2048+64) x 8 bit  | 1.8V |              | -40°C to 85°C | 63BGA 9 x 11   |
| 2 Gbit  | TC58BVG1S3HTAI0 | 2D-SLC | (2048+64) x 8 bit  | 3.3V | internal ECC | -40°C to 85°C | 48TSOP 12 x 20 |
| 2 Gbit  | TC58BVG1S3HBAI4 | ZD-SLC | (2048+64) x 8 bit  | 3.3V | Internal ECC | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BYG1S3HBAI6 |        | (2048+64) x 8 bit  | 1.8V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TC58BVG1S3HBAI6 |        | (2048+64) x 8 bit  | 3.3V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TH58BVG2S3HTA00 |        | (2048+64) x 8 bit  | 3.3V |              | 0°C to 70°C   | 48TSOP 12 x 20 |
|         | TC58BVG2S0HTA00 |        | (4096+128) x 8 bit | 3.3V |              | 0°C to 70°C   | 48TSOP 12 x 20 |
|         | TC58BVG2S0HTAI0 |        | (4096+128) x 8 bit | 3.3V |              | -40°C to 85°C | 48TSOP 12 x 20 |
|         | TH58BVG2S3HTAI0 |        | (2048+64) x 8 bit  | 3.3V |              | -40°C to 85°C | 48TSOP 12 x 20 |
|         | TH58BVG2S3HBAI4 |        | (2048+64) x 8 bit  | 3.3V |              | -40°C to 85°C | 63BGA 9 x 11   |
| 4 Gbit  | TH58BYG2S3HBAI4 | 2D-SLC | (2048+64) x 8 bit  | 1.8V | internal ECC | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BVG2S0HBAI4 |        | (4096+128) x 8 bit | 3.3V |              | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BYG2S0HBAI4 |        | (4096+128) x 8 bit | 1.8V |              | -40°C to 85°C | 63BGA 9 x 11   |
|         | TC58BVG2S0HBAI6 |        | (4096+128) x 8 bit | 3.3V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TC58BYG2S0HBAI6 |        | (4096+128) x 8 bit | 1.8V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TH58BYG2S3HBAI6 |        | (2048+64) x 8 bit  | 1.8V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TH58BVG3S0HTA00 |        | (4096+128) x 8 bit | 3.3V |              | 0° C to 70° C | 48TSOP 12 x 20 |
|         | TH58BYG3S0HBAI4 |        | (4096+128) x 8 bit | 1.8V |              | -40°C to 85°C | 63BGA 9 x 11   |
| 8 Gbit  | TH58BVG3S0HTAI0 | 2D-SLC | (4096+128) x 8 bit | 3.3V | internal ECC | -40°C to 85°C | 48TSOP 12 x 20 |
| 8 GDIL  | TH58BVG3S0HBAI4 | 2D-8LC | (4096+128) x 8 bit | 3.3V | internal ECC | -40°C to 85°C | 63BGA 9 x 11   |
|         | TH58BVG3S0HBAI6 |        | (4096+128) x 8 bit | 3.3V |              | -40°C to 85°C | 67BGA 6.5 x 8  |
|         | TH58BYG3S0HBAI6 |        | (4096+128) x 8 bit | 1.8V |              | -40°C to 85°C | 67BGA 6.5 x 8  |

#### e-MMC

| DENSITY | PART NUMBER         | TECHN.   | VCCQ          | JEDEC VERSION | TEMPERATURE       | PACKAGE           |
|---------|---------------------|----------|---------------|---------------|-------------------|-------------------|
| 4 GB    | THGBMNG5D1LBAIT     | 2D-MLC   | 1.8V or 3.3V  | e-MMC 5.0     | -25°C to 85°C     | 153FBGA 11 x 10   |
| 4 GB    | THGBMTG5D1LBAIL     | 2D-IVILG | 1.60 01 3.30  | e-iviivio 5.0 | -25°C to 85°C     | 153FBGA 11.5 x 13 |
| 8 GB    | THGBMUG6C1LBAIL     | 2D-MLC   | 1.8V or 3.3V  | e-MMC 5.1     | -25°C to 85°C     | 153FBGA 11.5 x 13 |
| o ab    | THGBMJG6C1LBAU7     | ZD-IVILO | 1.00 01 3.50  | e-MINIC 5.1   | -40°C to 105°C    | 153FBGA 11.5 x 13 |
|         | THGBMUG7C1LBAIL     | 2D-MLC   | 1.8V or 3.3V  | e-MMC 5.1     | -25°C to 85°C     | 153FBGA 11.5 x 13 |
| 16 GB   | THGBMJG7C2LBAU8     | 2D-IVILO | 1.60 01 3.30  |               | -40°C to 105°C    | 153FBGA 11.5 x 13 |
|         | THGAMVG7T13BAIL     | 3D-TLC   | 1.8V          |               | -25°C to 85°C     | 153FBGA 11.5 x 13 |
|         | THGBMUG8C2LBAIL     | 2D-MLC   | 1.8V or 3.3V  |               | -25°C to 85°C     | 153FBGA 11.5 x 13 |
| 32 GB   | THGBMJG8C4LBAU8     | ZD-IVILO | 1.00 01 3.30  | e-MMC 5.1     | -40° C to 105° C  | 153FBGA 11.5 x 13 |
|         | THGAMVG8T13BAIL     | 3D-TLC   | 1.8V          |               | -25°C to 85°C     | 153FBGA 11.5 x 13 |
|         | THGBMJG9C8LBAU8     | 2D-MLC   | 1.8V or 3.3V  |               | -40°C to 105°C    | 153FBGA 11.5 x 13 |
| 64 GB   | THGAMVG9T23BAIL     | 3D-TLC   | 1.8V          | e-MMC 5.1     | -25°C to 85°C     | 153FBGA 11.5 x 13 |
|         | NEW THGAMSG9T24BAIL | 3D-1LC   | 1.00          |               | -20 0 t0 85 C     | 153FBGA 11.5 x 13 |
| 128 GB  | THGAMVT0T43BAIR     | 3D-TLC   | 1.8V          | e-MMC 5.1     | -25°C to 85°C     | 153FBGA 11.5 x 13 |
| 120 00  | NEW THGAMST0T24BAIL |          | e-iviivio 5.1 | -20 C (0 85 C | 153FBGA 11.5 x 13 |                   |

#### UFS

| DENSITY | PART NUMBER         | TECHN. | VCC   VCCQ (3.X) | JEDEC VERSION | TEMPERATURE   | PACKAGE           |
|---------|---------------------|--------|------------------|---------------|---------------|-------------------|
| 128 GB  | THGJFAT0T44BAIL     | 3D-TLC | 2.5V   1.2V      | UFS 3.1       | -25°C to 85°C | 153FBGA 11.5 x 13 |
| 120 GB  | NEW THGJFJT0E25BAIP | 3D-1LC | 2.50   1.20      | UFS 4.0       | -20 C 10 60 C | 153FBGA 11 x 13   |
| 256 GB  | THGJFGT1E45BAIP     | 3D-TLC | 2.5V   1.2V      | UFS 3.1       | -25°C to 85°C | 153FBGA 11 x 13   |
| 250 GB  | NEW THGJFJT1E45BATP | 3D-1LC | 2.50   1.20      | UFS 4.0       | -20 C 10 60 C | 153FBGA 11 x 13   |
| 512 GB  | THGJFGT2T85BAIU     | 3D-TLC | 2.5V   1.2V      | UFS 3.1       | -25°C to 85°C | 153FBGA 11 x 13   |
| 512 GB  | NEW THGJFJT2T85BAT0 | 3D-TLC | 2.50   1.20      | UFS 4.0       | -25 C (0 85 C | 153FBGA 11 x 13   |
| 1 TB    | THGJFHT3TB4BAIF     | 3D-TLC | 2.5V   1.2V      | UFS 3.1       | -25°C to 85°C | 153FBGA 11.5 x 13 |







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